

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination YAMAZAKI ET AL.	
		Examiner A. Sefer	Art Unit 2826	Page 1 of 1

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	B	US-6,657,227	12-2003	Tamura et al.	257/64
	C	US-			
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	M	US-			

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*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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